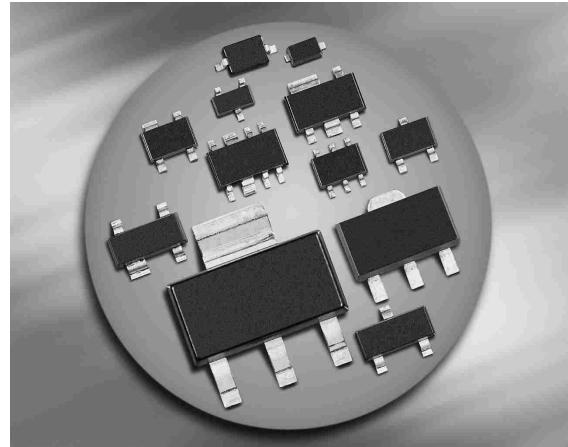


### Silicon Switching Diode

- For high-speed switching applications
- Common anode configuration



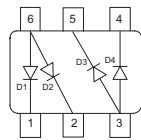
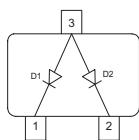
**BAW56**

**BAW56T**

**BAW56W**

**BAW56S**

**BAW56U**



Type	Package	Configuration	Marking
BAW56	SOT23	common anode	A1s
BAW56S	SOT363	double common anode	A1s
BAW56T	SC75	common anode	A1s
BAW56U	SC74	double common anode	A1s
BAW56W	SOT323	common anode	A1s

**Maximum Ratings at  $T_A = 25^\circ\text{C}$ , unless otherwise specified**

<b>Parameter</b>	<b>Symbol</b>	<b>Value</b>	<b>Unit</b>
Diode reverse voltage	$V_R$	80	V
Peak reverse voltage	$V_{RM}$	85	
Forward current	$I_F$	200	mA
Non-repetitive peak surge forward current $t = 1 \mu\text{s}$	$I_{FSM}$	4.5	A
$t = 1 \text{ ms}$		1	
$t = 1 \text{ s, single}$		0.5	
$t = 1 \text{ s, double}$		0.75	
Total power dissipation BAW56, $T_S \leq 28^\circ\text{C}$	$P_{tot}$	330	mW
BAW56S, $T_S \leq 85^\circ\text{C}$		250	
BAW56T, $T_S \leq 104^\circ\text{C}$		250	
BAW56U, $T_S \leq 90^\circ\text{C}$		250	
BAW56W, $T_S \leq 103^\circ\text{C}$		250	
Junction temperature	$T_j$	150	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-65 ... 150	

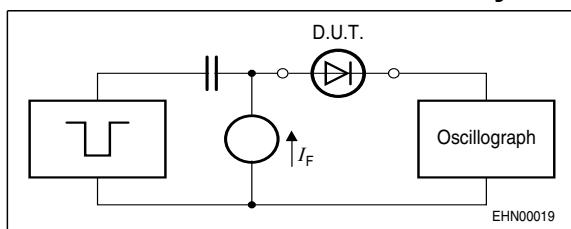
**Thermal Resistance**

<b>Parameter</b>	<b>Symbol</b>	<b>Value</b>	<b>Unit</b>
Junction - soldering point <sup>1)</sup> BAW56	$R_{thJS}$	360	K/W
BAW56S		260	
BAW56T		185	
BAW56U		240	
BAW56W		190	

<sup>1)</sup>For calculation of  $R_{thJA}$  please refer to Application Note Thermal Resistance

**Electrical Characteristics at  $T_A = 25^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>DC Characteristics</b>					
Breakdown voltage $I_{(\text{BR})} = 100 \mu\text{A}$	$V_{(\text{BR})}$	85	-	-	V
Reverse current $V_R = 70 \text{ V}$ $V_R = 25 \text{ V}, T_A = 150^\circ\text{C}$ $V_R = 70 \text{ V}, T_A = 150^\circ\text{C}$	$I_R$	-	-	0.15	$\mu\text{A}$
Forward voltage $I_F = 1 \text{ mA}$ $I_F = 10 \text{ mA}$ $I_F = 50 \text{ mA}$ $I_F = 100 \text{ mA}$ $I_F = 150 \text{ mA}$	$V_F$	-	-	715	mV
<b>AC Characteristics</b>					
Diode capacitance $V_R = 0 \text{ V}, f = 1 \text{ MHz}$	$C_T$	-	-	2	pF
Reverse recovery time $I_F = 10 \text{ mA}, I_R = 10 \text{ mA}$ , measured at $I_R = 1 \text{ mA}$ , $R_L = 100 \Omega$	$t_{rr}$	-	-	4	ns

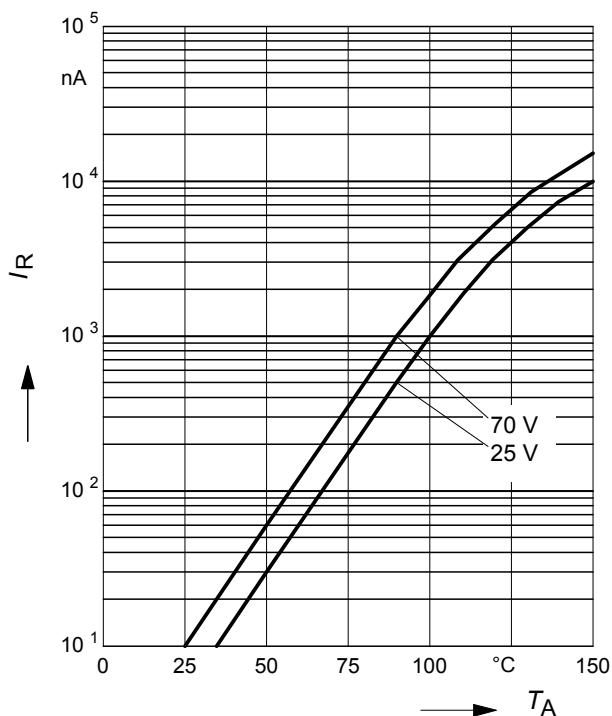
**Test circuit for reverse recovery time**


Pulse generator:  $t_p = 100\text{ns}$ ,  $D = 0.05$ ,  $t_r = 0.6\text{ns}$ ,  
 $R_i = 50\Omega$

Oscilloscope:  $R = 50\Omega$ ,  $t_r = 0.35\text{ns}$ ,  $C \leq 1\text{pF}$

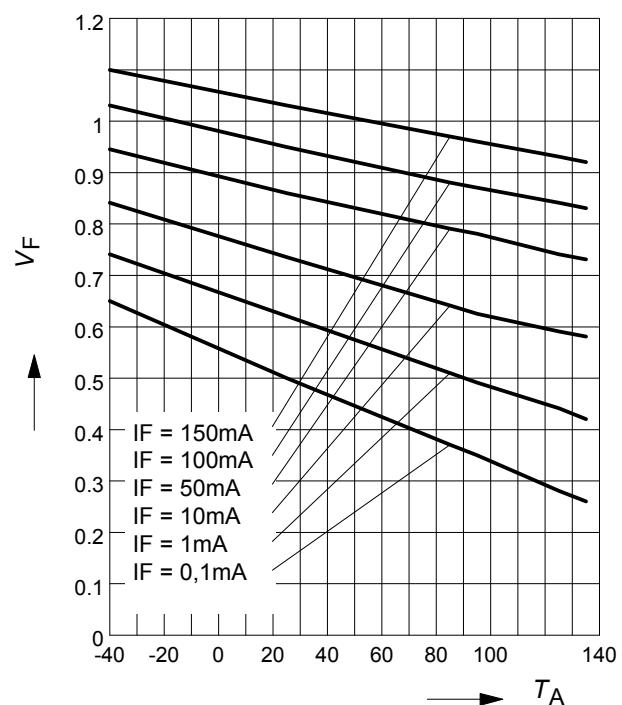
**Reverse current**  $I_R = f(T_A)$

$V_R$  = Parameter



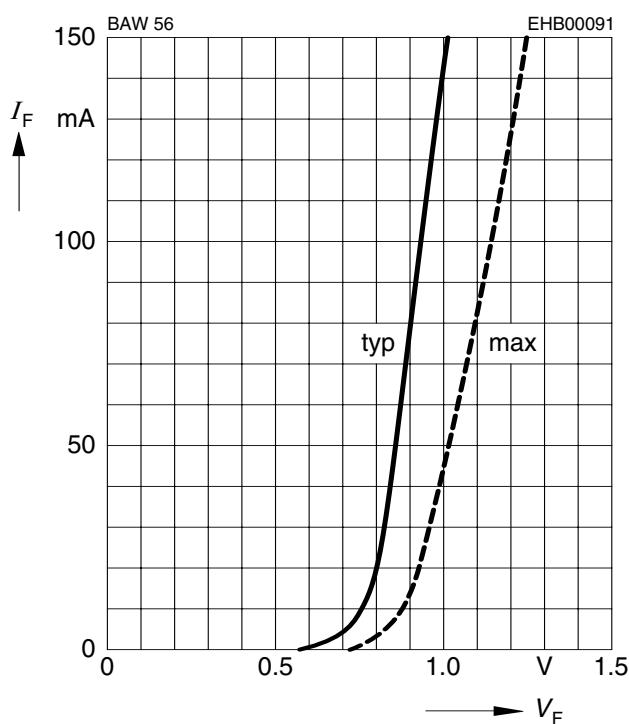
**Forward Voltage**  $V_F = f(T_A)$

$I_F$  = Parameter



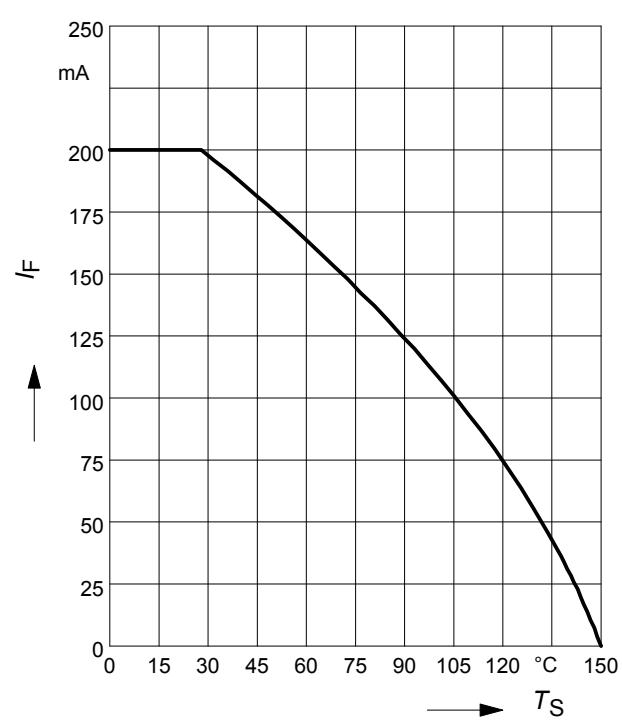
**Forward current**  $I_F = f(V_F)$

$T_A = 25^\circ\text{C}$



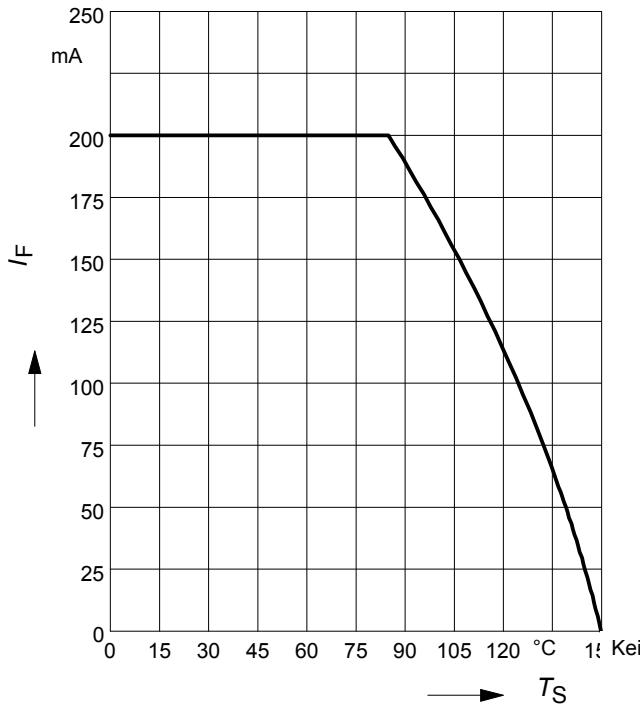
**Forward current**  $I_F = f(T_S)$

BAW56



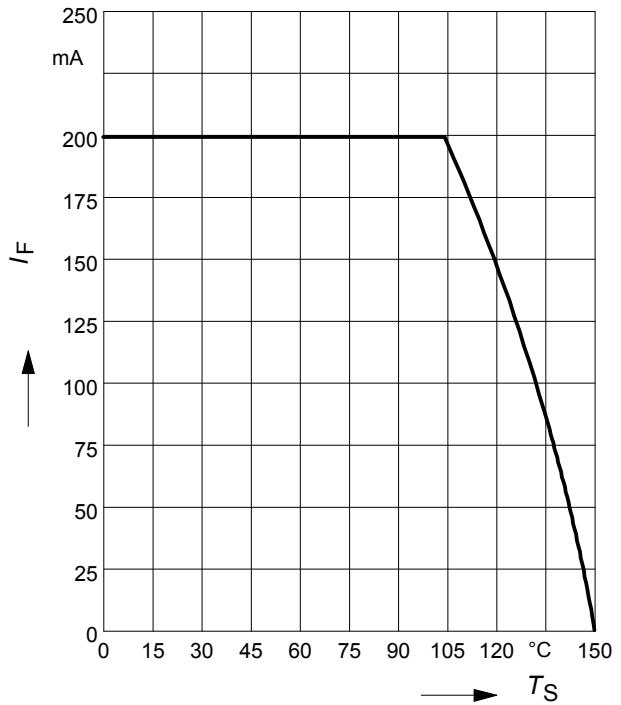
**Forward current  $I_F = f (T_S)$**

BAW56S



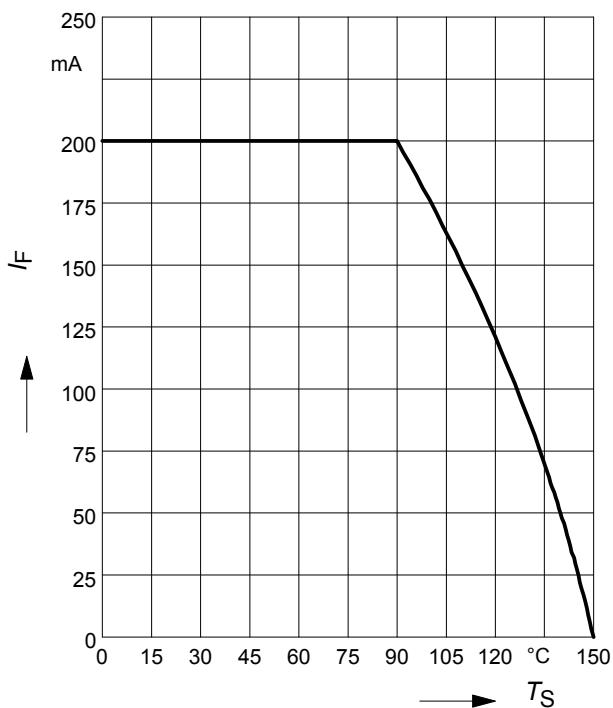
**Forward current  $I_F = f (T_S)$**

BAW56T



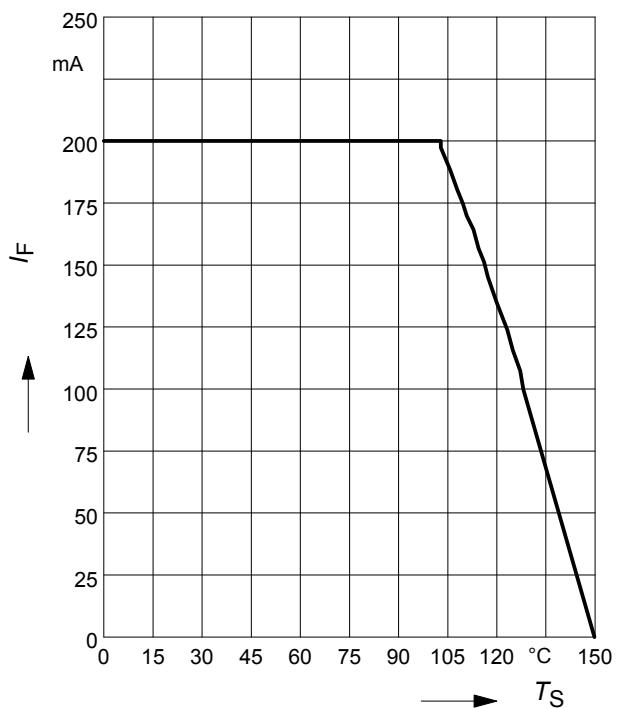
**Forward current  $I_F = f (T_S)$**

BAW56U



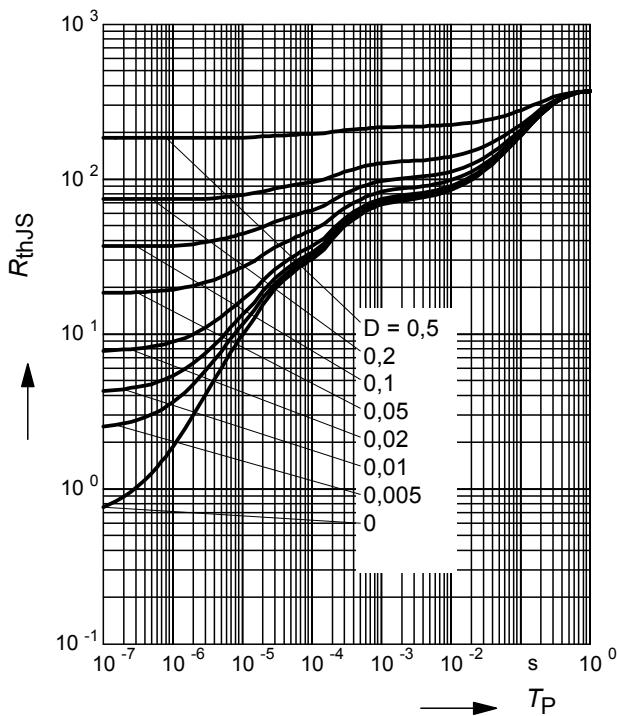
**Forward current  $I_F = f (T_S)$**

BAW56W



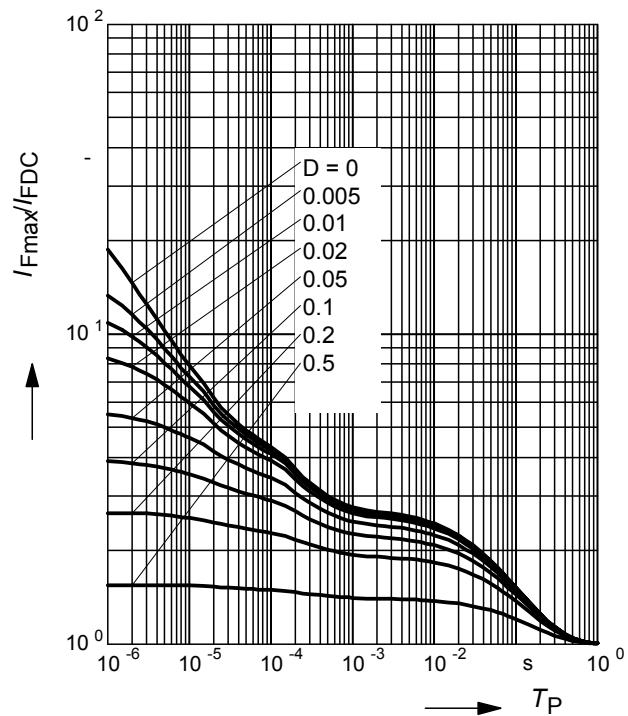
**Permissible Puls Load  $R_{\text{thJS}} = f(t_p)$** 

BAW56

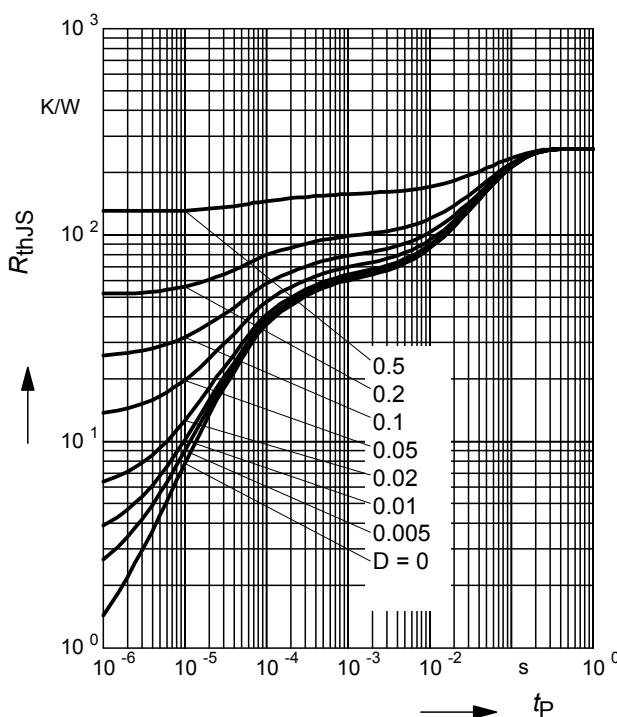

**Permissible Pulse Load**

$$I_{\text{Fmax}} / I_{\text{FDC}} = f(t_p)$$

BAW56

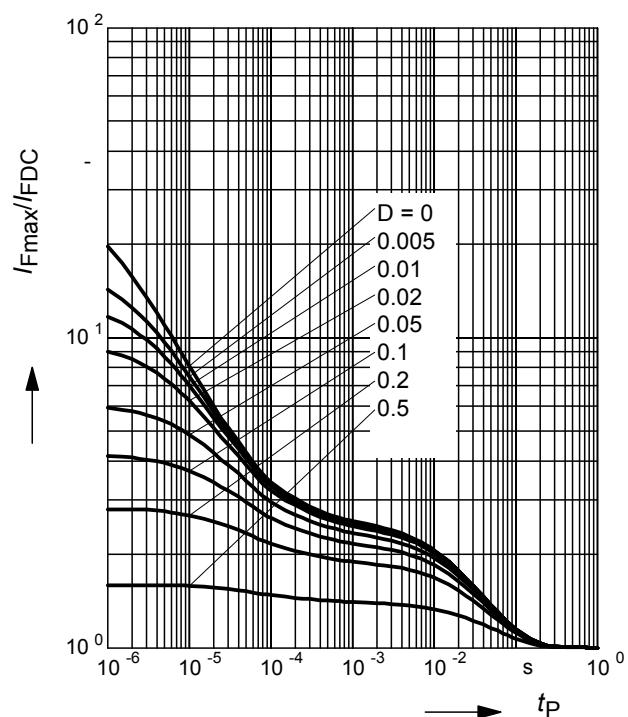

**Permissible Puls Load  $R_{\text{thJS}} = f(t_p)$** 

BAW56S


**Permissible Pulse Load**

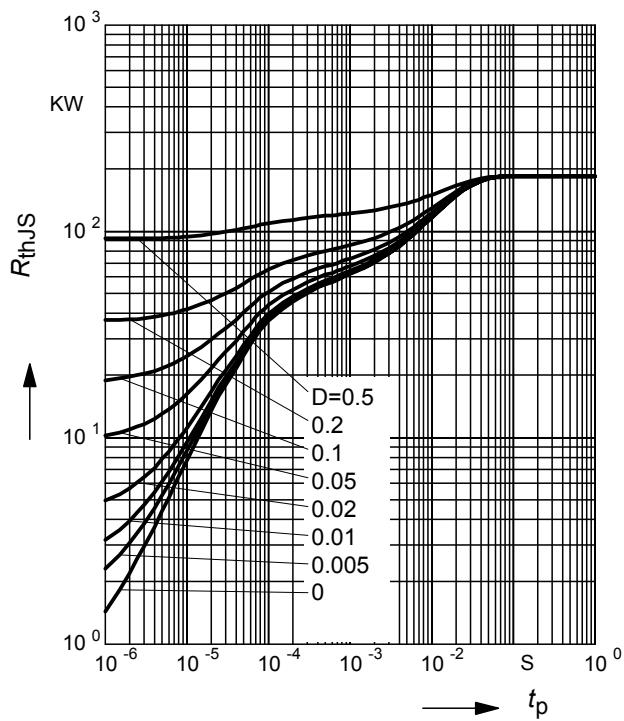
$$I_{\text{Fmax}} / I_{\text{FDC}} = f(t_p)$$

BAW56S



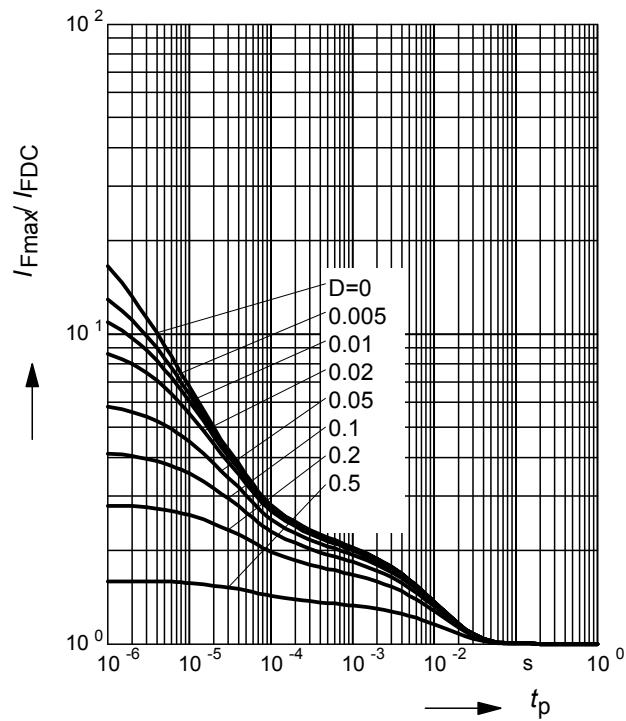
**Permissible Puls Load  $R_{\text{thJS}} = f(t_p)$** 

BAW56T

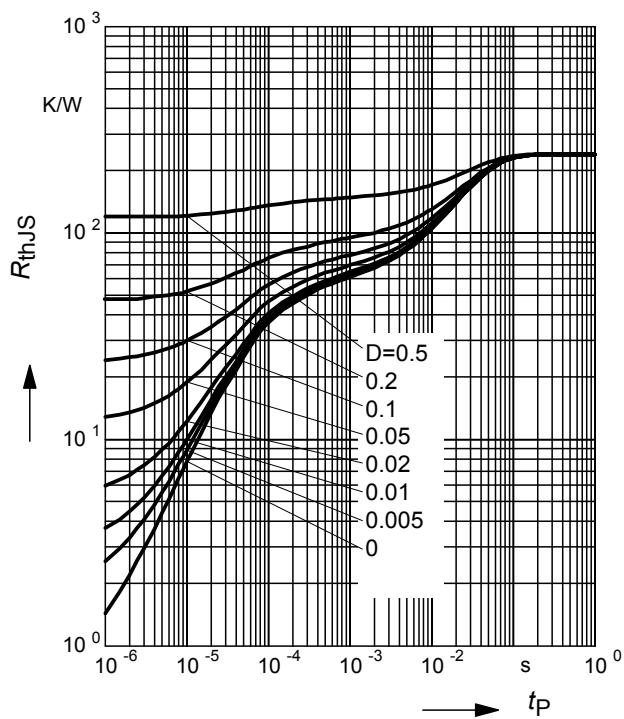

**Permissible Pulse Load**

$$I_{\text{Fmax}} / I_{\text{FDC}} = f(t_p)$$

BAW56T

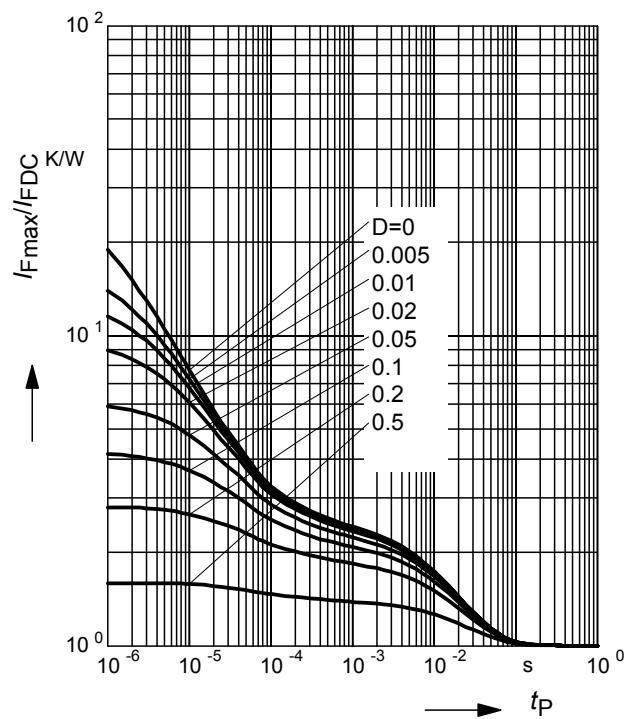

**Permissible Puls Load  $R_{\text{thJS}} = f(t_p)$** 

BAW56U


**Permissible Pulse Load**

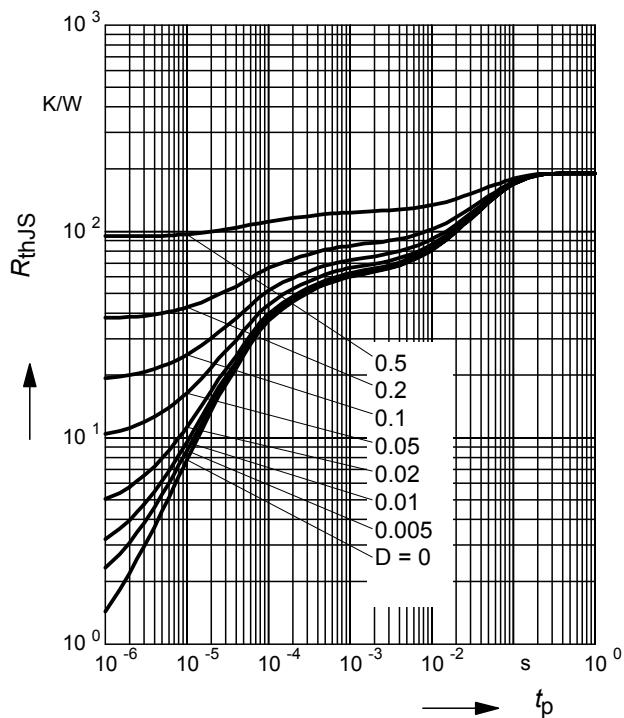
$$I_{\text{Fmax}} / I_{\text{FDC}} = f(t_p)$$

BAW56U



**Permissible Puls Load**  $R_{\text{thJS}} = f(t_p)$

BAW56W



**Permissible Pulse Load**

$I_{\text{Fmax}} / I_{\text{FDC}} = f(t_p)$

BAW56W

